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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/938,550	YANO ET AL.	
Examiner	Art Unit	
Yasin M. Barqadle	2153	

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Class	Subclass	Date	Examiner
709	204-207	6/8/2006	YB

INT	INTERFERENCE SEARCHED		
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SEARCH NOT (INCLUDING SEARCH		)
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East (US Patent, PG PUB, EPO, JPO and Derwent)	6/8/2006	YB
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